

N-Channel 60-V (D-S) MOSFET

| PRODUC | CT SUMMARY | | |
|---------------------|----------------------------------|---------------------------------|-----------------------|
| V _{DS} (V) | R _{DS(on)} (Ω) | I _D (A) ^a | Q _g (Typ.) |
| <u></u> | 0.076 at V _{GS} = 10 V | 4.5 | 10 nC |
| 60 | 0.085 at V _{GS} = 4.5 V | 3.5 | TOTIC |

FEATURES

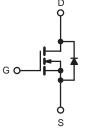
- Halogen-free
- TrenchFET[®] Power MOSFET

APPLICATIONS

· Load Switches for Portable Devices







N-Channel MOSFET

| Parameter | | Symbol | Limit | Unit | |
|---|------------------------|-----------------------------------|---------------------|------|--|
| Drain-Source Voltage | | V _{DS} | 60 | V | |
| Gate-Source Voltage | | V _{GS} | ± 20 | V | |
| | T _C = 25 °C | | 4.5 | | |
| Continuous Drain Current (T _{.1} = 150 °C) | T _C = 70 °C | | 3.2 ^a | | |
| Continuous Drain Current (1j = 150°C) | T _A = 25 °C | 'D | 2.7 | | |
| | T _A = 70 °C | 1 | 2.3 | A | |
| Pulsed Drain Current | | I _{DM} | 20 | | |
| Continuous Source-Drain Diode Current | T _C = 25 °C | I _S | 3.2 | | |
| Continuous Cource Drain Diode Current | T _A = 25 °C | '5 | 2.1 ^{b, c} | | |
| | T _C = 25 °C | | 4.0 | | |
| Maximum Power Dissipation | T _C = 70 °C | P _D | 3.0 | W | |
| Maximum rower Dissipation | T _A = 25 °C | | 2.5 ^{b, c} | | |
| | T _A = 70 °C | | 1.6 ^{b, c} | | |
| Operating Junction and Storage Temperature Range | | T _J , T _{stg} | - 55 to 150 | ℃ | |
| Soldering Recommendations (Peak Temper | | 260 | | | |

THERMAL RESISTANCE BATINGS

| Parameter | | Symbol | Typical | Maximum | Unit | | | |
|--|--------------------------------------|-------------------|---------|---------|------|--|--|--|
| Maximum Junction-to-Ambient ^{a, c, d} | t \leq 5 s R _{thJA} 40 50 | | °C/W | | | | | |
| Maximum Junction-to-Foot (Drain) | Steady State | R _{thJF} | 15 | 20 | 0/11 | | | |

Notes:

a. Package limited, T_C = 25 °C.
b. Surface Mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under Steady State conditions is 95 °C/W.

- e. See Reliability Manual for profile. The ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- f. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

| SPECIFICATIONS $T_J = 25 \ ^{\circ}C$, | | | Min | Turn | Mox | Lin:4 |
|--|-------------------------|--|----------|-------|-------|-----------|
| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit |
| Static | N/ | V _{GS} = 0 V, I _D = 250 μA | <u> </u> | 1 | | V |
| Drain-Source Breakdown Voltage | V _{DS} | $v_{GS} = 0 v, v_D = 250 \mu A$ | 60 | | | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | I _D = 250 μA | | 25 | | mV/°0 |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | | | - 4.0 | | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$ | 1.0 | | 2.5 | V |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 V, V_{GS} = \pm 12 V$ | | | ± 100 | nA |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ | | | 1 | |
| | .032 | $V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$ | | | 10 | μA |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \geq 5$ V, V_{GS} = 4.5 V | 30 | | | A |
| | Page | $V_{GS} = 10 \text{ V}$, $I_D = 4.0 \text{ A}$ | | 0.076 | | 0 |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | $V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 3.0 \text{ A}$ | 0.085 | | | Ω |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = 10 V, I _D = 4.0 A | | 45 | | S |
| Dynamic ^b | | | 1 | | • | |
| Input Capacitance | C _{iss} | | | 810 | | pF |
| Output Capacitance | C _{oss} | $V_{DS} = 30V^{,} V_{GS} = 0 V, f = 1 MHz$ | | 120 | | |
| Reverse Transfer Capacitance | C _{rss} | | | 100 | | |
| | | V _{DS} = 30 V, V _{GS} = 10 V, I _D = 4.0 A | | 22 | 33 | nC |
| Total Gate Charge | Qg | | | 10 | 15 | |
| Gate-Source Charge | Q _{gs} | V_{DS} = 30 V, V_{GS} = 4.5 V, I_{D} = 3.0 A | | 2.5 | | |
| Gate-Drain Charge | Q _{gd} | | | 1.7 | | |
| Gate Resistance | R _g | f = 1 MHz | | 2.4 | | Ω |
| Turn-on Delay Time | t _{d(on)} | | | 15 | 25 | |
| Rise Time | t _r | $V_{DD} = 30V, R_1 = 1.5 \Omega$ | | 10 | 15 | |
| Turn-Off Delay Time | t _{d(off)} | $I_D \cong 4.0 \text{ A}, \text{ V}_{\text{GEN}} = 4.5 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$ | | 35 | 55 | - ns - |
| Fall Time | t _f | | | 12 | 20 | |
| Turn-on Delay Time | t _{d(on)} | | | 10 | 15 | |
| Rise Time | t _r | V_{DD} = 30V , R_L = 1.5 Ω | | 12 | 20 | |
| Turn-Off Delay Time | t _{d(off)} | $I_D \cong 4.0 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$ | | 25 | 40 | |
| Fall Time | t _f | | | 10 | 15 | |
| Drain-Source Body Diode Characteristic | s | | I | 1 | | |
| Continuous Source-Drain Diode Current | ۱ _S | T _C = 25 °C | | | 7.2 | |
| Pulse Diode Forward Current | I _{SM} | | | | 30 | A |
| Body Diode Voltage | V _{SD} | I _S = 4.0 A, V _{GS} = 0 V | | 0.8 | 1.2 | V |
| Body Diode Reverse Recovery Time | t _{rr} | | | 20 | 40 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | | | 10 | 20 | nC |
| Reverse Recovery Fall Time | ta | $I_F = 4.0 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{T}_J = 25 ^\circ\text{C}$ | | 10 | | |
| | | | | | | ns |
| Reverse Recovery Rise Time lotes: | t _b | | | 10 | | |

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %

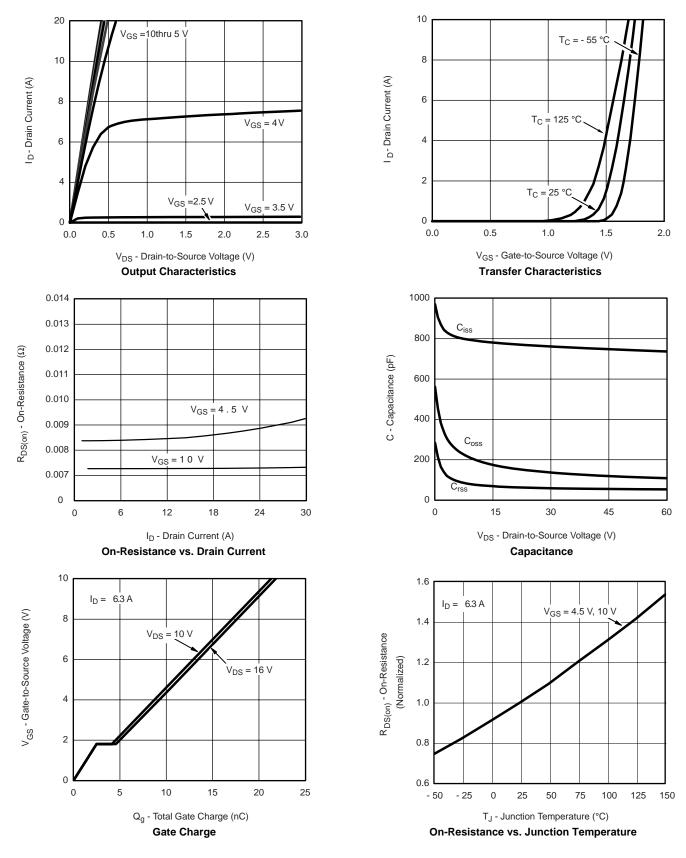
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

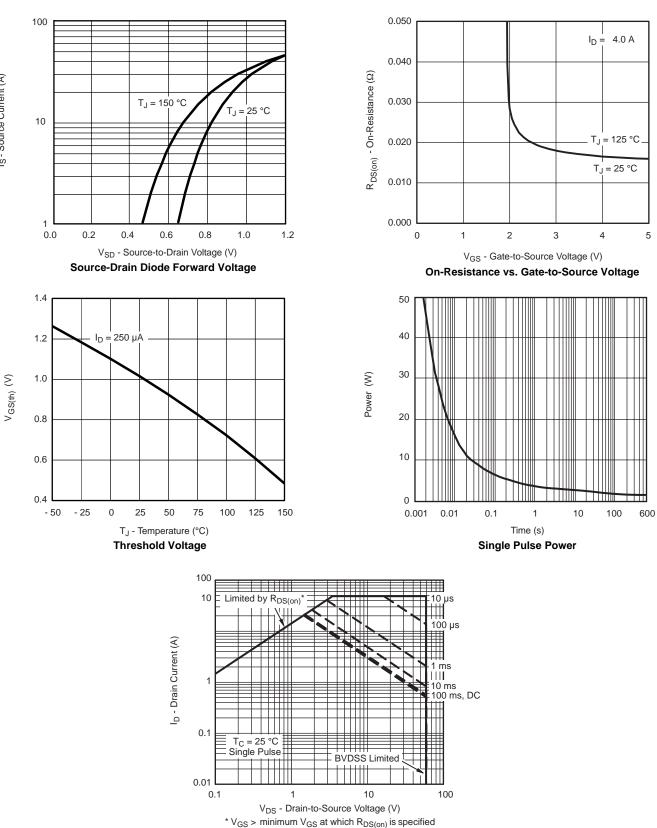
emi



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Is - Source Current (A)



Single Pulse Power, Junction-to-Case

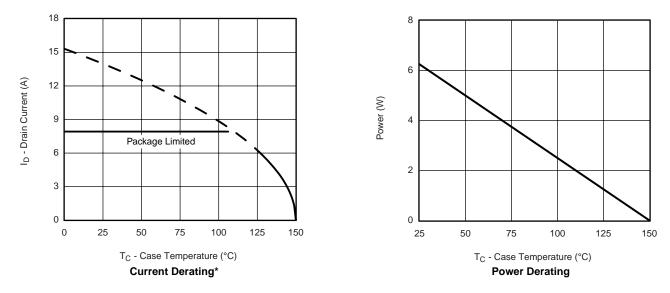
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



emi



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

2 1 Duty Cycle = 0.5 + + + + + + 0.2 ffecti H Notes: 0.1 4 P_{DM} 0.1 0.05 t₁ t₂ +t₁ 0.02 1. Duty Cycle, D = 1. Duty Cycle, D = $\frac{1}{t_2}$ 2. Per Unit Base = R_{thJA} 80 °C/W 3. $T_{JM} - T_A = P_{DM}Z_{thJA}^{(t)}$ Single Pulse 4. Surface Mounted 0.01 10-4 10⁻³ 10⁻² 10-1 1 10 100 600 Square Wave Pulse Duration (s) Normalized Thermal Transient Impedance, Junction-to-Ambient 2 1 Duty Cycle = 0.5 Normalized Effective Transient Thermal Impedance HE 0.2 0.1 0.1 0.05 0.02 Single Pulse 0.01 10-4 10⁻³ 10-2 10-1 1 10 Square Wave Pulse Duration (s)

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

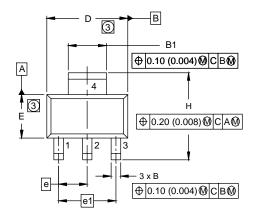


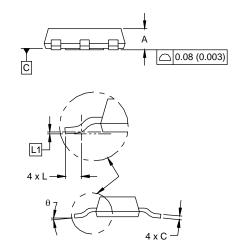
semi

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SOT-223 (HIGH VOLTAGE)





| DIM. | MILLI | METERS | INCHES | |
|------|-----------|--------|------------|-------|
| | MIN. | MAX. | MIN. | MAX. |
| А | 1.55 | 1.80 | 0.061 | 0.071 |
| В | 0.65 | 0.85 | 0.026 | 0.033 |
| B1 | 2.95 | 3.15 | 0.116 | 0.124 |
| С | 0.25 | 0.35 | 0.010 | 0.014 |
| D | 6.30 | 6.70 | 0.248 | 0.264 |
| E | 3.30 | 3.70 | 0.130 | 0.146 |
| е | 2.30 BSC | | 0.0905 BSC | |
| e1 | 4.60 BSC | | 0.181 BSC | |
| Н | 6.71 | 7.29 | 0.264 | 0.287 |
| L | 0.91 | - | 0.036 | - |
| L1 | 0.061 BSC | | 0.002 | 4 BSC |
| θ | - | 10' | - | 10' |

Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Dimensions are shown in millimeters (inches).

3. Dimension do not include mold flash.

4. Outline conforms to JEDEC outline TO-261AA.



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